Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/624,224	TANAKA ET AL.	
Examiner	Art Unit	
Andrew Schechter	2871	

	SEAR	CHED	
Class	Subclass	Date	Examiner
349	149	4/7/2005	AI
349	151	4/7/2005	AT
349	152	4/7/2005	M
324	770	4/7/2005	B
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INT	INTERFERENCE SEARCHED			
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